# SourceMeter® SMU Instruments



- Five instruments in one (IV Source, IVR Measure)
- Seven models: 20–100W DC, 1000W pulsed, 1100V to 1µV, 10A to 10pA
- Source and sink (4-quadrant) operation
- 0.012% basic measure accuracy with 6½-digit resolution
- 2-, 4-, and 6-wire remote
   V-source and measure sensing
- 1700 readings/second at 4½ digits via GPIB
- Pass/Fail comparator for fast sorting/binning
- Available high speed sense lead contact check function
- Programmable DIO port for automation/handler/prober control (except Model 2401)
- Standard SCPI GPIB, RS-232 and Keithley Trigger Link interfaces
- Keithley LabTracer 2.0 I-V curve tracing application software (download)

Keithley's Series 2400 Source Measure Unit (SMU) Instruments are designed specifically for test applications that demand tightly coupled sourcing and measurement. All SourceMeter models provide precision voltage and current sourcing as well as measurement capabilities. Each SourceMeter SMU instrument is both a highly stable DC power source and a true instrument-grade 6½-digit multimeter. The power source characteristics include low noise, precision, and readback. The multimeter capabilities include high repeatability and low noise. The result is a compact, single-channel, DC parametric tester. In operation, these instruments can act as a voltage source, a current source, a voltage meter, a current meter, and an ohmmeter. Manufacturers of components and modules for the communications, semiconductor, computer, automotive, and medical industries will find the SourceMeter SMU instruments invaluable for a wide range of characterization and production test applications.

### **Advantages of a Tightly Integrated Instrument**

By linking source and measurement circuitry in a single unit, these instruments offer a variety of advantages over systems configured with separate source and measurement instruments. For example, they minimize the time required for test station development, setup, and maintenance, while lowering the overall cost of system ownership. They simplify the test process itself

by eliminating many of the complex synchronization and connection issues associated with using multiple instruments. And, their compact half-rack size conserves precious "real estate" in the test rack or bench.

#### Power of Five Instruments in One (IV Source, IVR Measure)

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The tightly coupled nature of a SourceMeter SMU instrument provides many advantages over solutions configured from separate instruments, such as a precision power supply and a digital multimeter. For example, it provides faster test times by reducing GPIB traffic and simplifies the remote programming interface. It also protects the device under test from damage due to accidental overloads, thermal runaway, etc. Both the current and voltage source are programmable with readback to help maximize device measurement integrity. If the readback reaches a programmed compliance limit, then the source is clamped at the limit, providing fault protection.

### **ACCESSORIES AVAILABLE**

TEST LEA	DS AND PROBES	COMMUNIC	CATION INTERFACE		
1754	2-Wire Universal 10-Piece Test Lead Kit	KPCI-488LPA	IEEE-488 Interface/Controller for the PCI Bus		
5804	Kelvin (4-Wire) Universal 10-Piece Test Lead Kit	KUSB-488B	IEEE-488 USB-to-GPIB Interface Adapter		
5805	Kelvin (4-Wire) Spring-Loaded Probes	TRIGGERIN	G AND CONTROL		
5808	Low Cost Single-pin Kelvin Probe Set	2499-DIGIO	Digital I/O Expander Assembly		
5809	Low Cost Kelvin Clip Lead Set	,,	(not for Model 2401)		
8607	2-Wire, 1000V Banana Cables, 1m (3.3 ft)	8501-1	Trigger Link Cable, DIN-to-DIN, 1m (3.3 ft)		
CA-18-1	Shielded Dual Banana Cable, 1.2m (4 ft)	8501-2	Trigger Link Cable, DIN-to-DIN, 2m (6.6 ft)		
SWITCHI	NG HARDWARE	8502	Trigger Link to BNC Breakout Box		
7001	Two-Slot Switch System	8503	Trigger Link Cable, DIN-to-Dual BNC, 1m (3.3 ft)		
7002	Ten-Slot Switch System	8505	Male to 2-Female Y-DIN Cable for Trigger Link		
7019-C	6-Wire Ohms Switch Card	RACK MOU	NT KITS		
7053	High-Current Switch Card	4288-1	Single Fixed Rack Mount Kit		
CABLES/	ADAPTERS	4288-2	Dual Fixed Rack Mount Kit		
7007-1	Shielded GPIB Cable, 1m (3.3 ft)	4288-4	Dual Fixed Rack Mount Kit		
7007-2	Shielded GPIB Cable, 2m (6.6 ft)	4288-5	Shelf Type Side by Side Rack Mounting Kit		
7009-5	RS-232 Cable	4288-9	Dual Fixed Rack Mounting Kit		
8620	620 Shorting Plug				
		LabTracer 2.0	Curve Tracing Software (downloadable)		

1.888.KEITHLEY (U.S. only)

www.keithlev.com



### **Ordering Information**

2400 200V, 1A, 20W SourceMeter SMU Instrument

2400-C 200V, 1A, 20W
SourceMeter SMU
Instrument with Contact
Check

2401 20V, 1A, 20W SourceMeter SMU Instrument

2410 1100V, 1A, 20W SourceMeter SMU Instrument

2410-C 1100V, 1A, 20W SourceMeter SMU Instrument with Contact Check

2420 60V, 3A, 60W SourceMeter SMU Instrument

2420-C 60V, 3A, 60W SourceMeter SMU Instrument with Contact Check

2425 100V, 3A, 100W SourceMeter SMU Instrument

2425-C 100V, 3A, 100W SourceMeter SMU Instrument with Contact Check

2430 100V, 10A, 1000W Pulse Mode SourceMeter SMU Instrument

2430-C 100V, 10A, 1000W Pulse Mode SourceMeter SMU Instrument with Contact Check

2440 40V, 5A, 50W SourceMeter SMU Instrument

2440-C 40V, 5A, 50W SourceMeter SMU Instrument with Contact Check

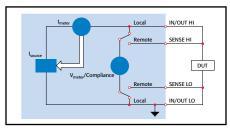
#### Accessories Supplied

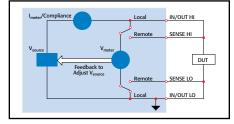
Model 8605 Test Leads LabVIEW Software Driver (downloadable) LabTracer Software (downloadable)

# SourceMeter® SMU Instruments

#### **I-V Characteristics**

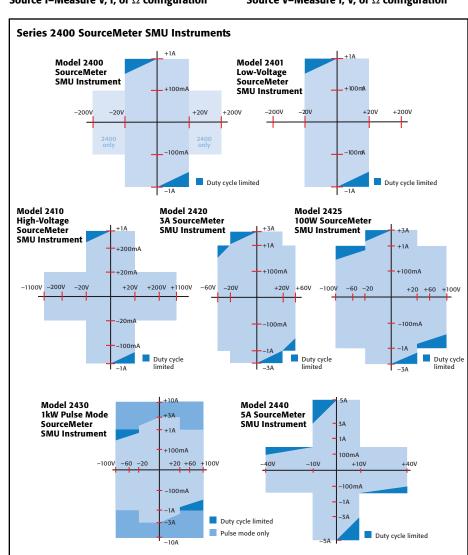
All SourceMeter SMU instruments provide four-quadrant operation. In the first and third quadrants they operate as a source, delivering power to a load. In the second and fourth quadrants they operate as a sink, dissipating power internally. Voltage, current, and resistance can be measured during source or sink operation.





Source I–Measure V, I, or  $\Omega$  configuration

Source V–Measure I, V, or  $\Omega$  configuration







# SourceMeter® SMU Instruments

### **Automation for Speed**

A SourceMeter SMU instrument streamlines production testing. It sources voltage or current while making measurements without needing to change connections. It is designed for reliable operation in non-stop production environments. To provide the throughput demanded by production applications, the SourceMeter SMU instrument offers many built-in features that allow it to run complex test sequences without computer control or GPIB communications slowing things down.

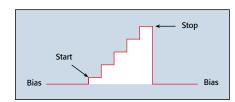
### **Standard and Custom Sweeps**

Sweep solutions greatly accelerate testing with automation hooks. Three basic sweep waveforms are provided that can be programmed for single-event or continuous operation. They are ideal for I/V. I/R. V/I. and V/R characterization.

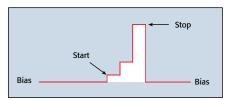
- Linear Staircase Sweep: Moves from the start level to the stop level in equal linear steps
- Logarithmic Staircase Sweep: Done on a log scale with a specified number of steps per decade
- Custom Sweep: Allows construction of special sweeps by specifying the number of measurement points and the source level at each point
- Up to 1700 readings/second at  $4\frac{1}{2}$  digits to the GPIB bus
- 5000 readings can be stored in the nonvolatile buffer memory

# **Built-In Test Sequencer** (Source Memory List)

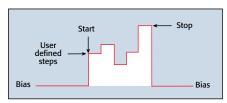
The Source Memory list provides faster and easier testing by allowing you to setup and execute up to 100 different tests that run without PC intervention.



Linear staircase sweep



Logarithmic staircase sweep



**Custom sweep** 

- Stores up to 100 instrument configurations, each containing source settings, measurement settings, pass/fail criteria, etc.
- Pass/fail limit test as fast as 500µs per point
- · Onboard comparator eliminates the delay caused when sending data to the computer for analysis
- · Built-in, user definable math functions to calculate derived parameters

#### **TYPICAL APPLICATIONS**

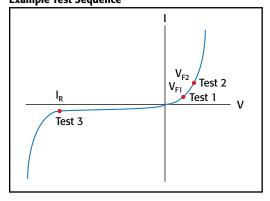
#### **Devices:**

- Discrete semiconductor devices
- Passive devices
- · Transient suppression devices
- ICs, RFICs, MMICs
- Laser diodes, laser diode modules, LEDs, photodetectors
- Circuit protection devices: TVS, MOV, Fuses, etc.
- Airbags
- · Connectors, switches, relays
- High brightness LEDs (DC and pulse)

#### Tests:

- Leakage
- Low voltage/resistances
- LIV
- · IDDO
- I-V characterization
- Isolation and trace resistance
- Temperature coefficient
- Forward voltage, reverse breakdown, leakage current
- DC parametric test
- DC power source
- HIPOT
- Photovoltaic cell efficiency (source and sink)
- · Dielectric withstanding

### **Example Test Sequence**



Test	Pass/Fail Test	If Passes Test	If Fails Test
Test 1	Check V <sub>F1</sub> at 100mA against pass/fail limits	Go to Test 2	
Test 2	Check V <sub>F2</sub> at 1A against pass/fail limits	Go to Test 3	Bin part to bad bin     Transmit data to computer while
Test 3	Check leakage current at -500V and test against pass/fail limits	Bin part to good bin     Transmit readings to computer while handler is placing new part     Return to Test 1	handler is placing new part 3. Return to Test 1





# SourceMeter® SMU Instruments

### Digital I/O Interface

The digital I/O interface can link a SourceMeter SMU instrument to many popular component handlers, including Aetrium, Aeco, and Robotronics. Other capabilities of the interface include:

- Tight systems integration for applications such as binning and sorting
- Built-in component handler interface
- Start of test and end of test signals
- 5V, 300mA power supply
- Optional expander accessory (Model 2499-DIGIO) adds 16 digital I/O lines

The digital I/O interface is available on all Series 2400 SoourceMeter instruments except the Model 2401.

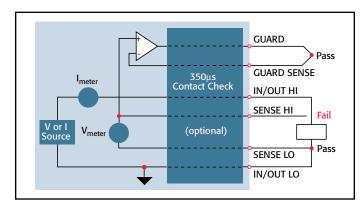
### **Trigger Link Interface**

All SourceMeter SMU instruments include Keithley's unique Trigger Link interface which provides high-speed, seamless communications with many of Keithley's other instruments. For example, use the Trigger Link interface to connect a SourceMeter SMU instrument with a Series 7000 Switching System for a complete multi-point test solution. With Trigger Link, the Series 7000 Switching Systems can be controlled by a SourceMeter SMU instrument during a high-speed test sequence independent of a computer and GPIB.

### **Optional Contact Check Function**

The Contact Check function makes it simple to verify good connections quickly and easily before an automated test sequence begins. This eliminates measurement errors and false product failures associated with contact fatigue, breakage, contamination, loose or broken connection, relay failures, etc. Some capabilities of this function are:

- 350µs verification and notification process time
- The output of the SourceMeter SMU instrument is automatically shut off after a fault and is not re-activated until good contact is verified, protecting the device under test from damage and the operator from potential safety hazards.
- 3 pass/fail threshold values:  $2\Omega$ ,  $15\Omega$ , and  $50\Omega$
- No energy passes through the device under test during the operation.
- Enabled either from the front panel or remotely over the GPIB
- 3 fault notification methods

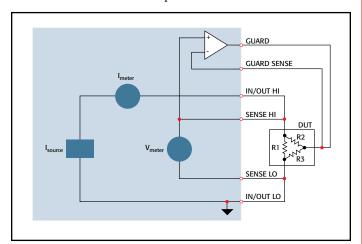


Contact check option for 4-wire or 6-wire applications

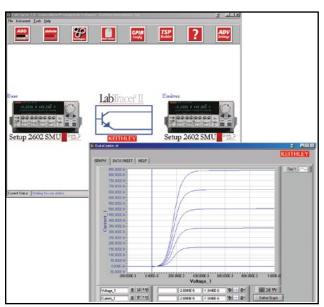
### **Unique 6-Wire Ohms Technique**

SourceMeter SMU instruments can make standard 4-wire, split Kelvin, and 6-wire, guarded ohms measurements and can be configured for either the constant current or constant voltage method. The 6-wire ohms technique:

- Uses guard and guard sense leads in addition to the 4-wire sense and source leads.
- Locks out parallel current paths when measuring resistor networks or hybrid circuits to isolate the component under test.
- Allows users to configure and plot data easily from Series 2400 SourceMeter SMU instruments, making characterization of two, three, and four terminal devices a snap.



6-Wire Ohms Circuit. All test current flows through R1 because the high current guard drives the voltage across R2 to 0V.



Free LabTracer 2.0 device characterization software (downloadable)





# SourceMeter® SMU Instruments

### **Voltage Accuracy (Local or Remote Sense)**

Model	Range	Programming Resolution	Source <sup>1</sup> Accuracy (1 Year) 23°C ±5°C ±(% rdg. + volts)	Default Measurement Resolution	Measurement <sup>2, 3, 4</sup> Accuracy (1 Year) 23°C ±5°C ±(% rdg. + volts)	Output Slew Rate (±30%)	Source/Sink Limit
	200.000 mV	5 μV	$0.02\% + 600 \mu\text{V}$	1 μV	$0.012\% + 300 \mu V$		
2400, 2400-С,	2.00000 V	50 μV	$0.02\% + 600 \mu\text{V}$	10 μV	$0.012\% + 300 \mu V$		±21 V @ ±1.05 A
2401	20.0000 V	500 μV	0.02% + 2.4  mV	$100 \mu V$	0.015% + 1.5  mV	$0.08 \text{ V/}\mu\text{s}$	±210 V @ ±105 mA*
	200.000 V*	5 mV	0.02% + 24  mV	1 mV	0.015% + 10 mV	0.5 V/μs	
	200.000 mV	5 μV	$0.02\% + 600 \mu\text{V}$	1 μV	$0.012\% + 300 \mu V$		
2/10 2/10 6	2.00000 V	50 μV	$0.02\% + 600 \mu\text{V}$	10 μV	$0.012\% + 300 \mu V$		±21 V @ ±1.05 A
2410, 2410-С	20.0000 V	500 μV	0.02% + 2.4  mV	100 μV	0.015% + 1 mV	0.15 V/μs	±1100 V @ ±21 mA
	1000.00 V	50 mV	0.02% + 100 mV	10 mV	0.015% + 50 mV	0.5 V/μs	
	200.000 mV	5 μV	$0.02\% + 600 \mu\text{V}$	1 μV	$0.012\% + 300 \mu V$		
2420, 2420-С	2.00000 V	50 μV	$0.02\% + 600 \mu\text{V}$	10 μV	$0.012\% + 300 \mu V$		±21 V @ ±3.15 A
2420, 2420-C	20.0000 V	500 μV	0.02% + 2.4  mV	$100~\mu V$	0.015% + 1  mV	$0.08 \text{ V/}\mu\text{s}$	±63 V @ ±1.05 A
	60.0000 V	1.5 mV	0.02% + 7.2 mV	1 mV	0.015% + 3 mV	0.14 V/μs	
	200.000 mV	5 μV	$0.02\% + 600 \mu\text{V}$	1 μV	$0.012\% + 300 \mu V$		
2425, 2425-C	2.00000 V	50 μV	$0.02\% + 600 \mu\text{V}$	10 μV	$0.012\% + 300 \mu V$		±21 V @ ±3.15 A
2425, 2425-0	20.0000 V	500 μV	0.02% + 2.4  mV	$100~\mu V$	0.015% + 1  mV	$0.08~ ext{V}/\mu ext{s}$	±105 V @ ±1.05 A
	100.0000 V	2.5 mV	0.02% + 12 mV	1 mV	0.015% + 5 mV	0.25 V/μs	
	200.000 mV	5 μV	$0.02\% + 600 \mu\text{V}$	1 μV	$0.012\% + 300 \mu V$		±105 V @ ±1.05 A
2430, 2430-С	2.00000 V	50 μV	$0.02\% + 600 \mu\text{V}$	10 μV	$0.012\% + 300 \mu V$		
2450, 2450-C	20.0000 V	500 μV	0.02% + 2.4  mV	$100~\mu V$	0.015% + 1  mV	$0.08~ ext{V}/\mu ext{s}$	±105 V @ ±10.5 A
	100.0000 V	2.5 mV	0.02% + 12 mV	1 mV	0.015% + 5 mV	0.25 V/μs	(pulse mode only)
	200.000 mV	5 μV	$0.02\% + 600 \mu\text{V}$	1 μV	$0.012\% + 300 \mu V$		
2440, 2440-С	2.00000 V	50 μV	$0.02\% + 600 \mu\text{V}$	10 μV	$0.012\% + 300 \mu V$		±10.5 V @ ±5.25 A
4110, 4110-C	10.0000 V	500 μV	0.02% + 1.2  mV	$100~\mu V$	$0.015\% + 750 \mu V$	$0.08 \text{ V/}\mu\text{s}$	±42 V @ ±1.05 A
	40.0000 V	5 mV	0.02% + 4.8 mV	1 mV	0.015% + 3 mV	0.25 V/μs	

<sup>\*</sup>Not available on Model 2401.

TEMPERATURE COEFFICIENT (0°-18°C and 28°-50°C):  $\pm (0.15 \times \text{accuracy specification})$ /°C. VOLTAGE REGULATION: Line: 0.01% of range. Load: 0.01% of range + 100 $\mu$ V.

OVER VOLTAGE PROTECTION: User selectable values, 5% tolerance. Factory default = none. CURRENT LIMIT: Bipolar current limit (compliance) set with single value. Min. 0.1% of range. OVERSHOOT: <0.1% typical (full scale step, resistive load, 10mA range).

### **ADDITIONAL SOURCE SPECIFICATIONS (All Models)**

TRANSIENT RESPONSE TIME:  $30\mu s$  minimum for the output to recover to its spec. following a step change in load.

COMMAND PROCESSING TIME: Maximum time required for the output to begin to change following the receipt of :SOURce:VOLTage | CURRent <nrf> command. Autorange On: 10ms. Autorange Off: 7ms.

OUTPUT SETTLING TIME: Time required to reach 0.1% of final value after command is processed. 100µs typical. Resistive load. 10µA to 100mA range.

DC FLOATING VOLTAGE: Output can be floated up to ±250VDC (Model 2440 ±40VDC) from chassis ground.

REMOTE SENSE: Up to 1V drop per load lead.

COMPLIANCE ACCURACY: Add 0.3% of range and  $\pm 0.02\%$  of reading to base specification. OVER TEMPERATURE PROTECTION: Internally sensed temperature overload puts unit in

RANGE CHANGE OVERSHOOT: Overshoot into a fully resistive 100kΩ load, 10Hz to 1MHz BW, adjacent ranges: 100mV typical, except 20V/200V (20V/60V on Model 2420), 20V/100V on Model

2425 and 2430, range boundary, and Model 2440. MINIMUM COMPLIANCE VALUE: 0.1% of range.

# ADDITIONAL PULSE MODE SOURCE SPECIFICATIONS (2430 and 2430-C only)

MAXIMUM DUTY CYCLE: 8%, hardware limited, 10A range only. All other ranges 100%. MAXIMUM PULSE WIDTH: 5ms from 90% rising to 90% falling edge, 2.5ms 10A range. MINIMUM PULSE WIDTH: 150\(\alpha\)s.

MINIMUM PULSE RESOLUTION: 50µs typical, 70µs max., limited by system jitter. SOURCE ACCURACY: Determined by settling time and source range specifications.

**OUTPUT SETTLING TIME 0.1%:** 

 $800\mu s$  typ., source I = 10A into  $10\Omega$ , limited by voltage slew rate.

 $500\mu s$  typ., source I = 10A into  $1\Omega$ , limited by voltage slew rate.

**OUTPUT SLEW RATE:** 

Voltage (10Ω load):  $0.25V/\mu s \pm 30\%$  on 100V range.  $0.08V/\mu s \pm 30\%$  on 20V range, 10A range. Current (0Ω load):  $0.25A/\mu s \pm 30\%$  on 100V range.  $0.08A/\mu s \pm 30\%$  on 20V range, 10A range.

#### NOTES

- 2400, 2401, 2410 Only: Specifications valid for continuous output currents below 105mA. For operation above 105mA continuous for >1 minute, derate accuracy 10%/35mA above 105mA.
- Speed = Normal (1 PLC). For 0.1 PLC, add 0.005% of range to offset specifications, except 200mV, 1A, 10A
  ranges, add 0.05%. For 0.01 PLC, add 0.05% of range to offset specifications, except 200mV, 1A, 10A ranges, add
  0.5%
- 3. Accuracies apply to 2- or 4-wire mode when properly zeroed.
- 4. In pulse mode, limited to 0.1 PLC measurement





# SourceMeter® SMU Instruments

### **Current Accuracy (Local or Remote Sense)**

Model	Range	Programming Resolution	Source <sup>1, 3</sup> Accuracy (1 Year) 23°C ±5°C ±(% rdg. + amps)	Default Measurement Resolution	Measurement <sup>5, 6, 7</sup> Accuracy (1 Year) 23°C ±5°C ±(% rdg. + amps)	Source/Sink Limit
	1.00000 μΑ	50 pA	0.035% + 600 pA	10 pA	0.029% + 300 pA	
	10.0000 μΑ	500 pA	0.033% + 2 nA	100 pA	0.027% + 700 pA	
	100.000 μA	5 nA	0.031% + 20 nA	1 nA	0.025% + 6 nA	
2400, 2400-C,	1.00000 mA	50 nA	0.034% + 200 nA	10 nA	0.027% + 60 nA	±1.05A @ ±21 V
2401	10.0000 mA	500 nA	$0.045\% + 2 \mu A$	100 nA	0.035% + 600 nA	±105 mA @ ±210 V8
	100.000 mA	5 μΑ	$0.066\% + 20 \mu\text{A}$	$1 \mu A$	$0.055\% + 6 \mu A$	
	$1.00000~A^2$	50 μA	$0.27 \% + 900 \mu A$	10 μA	$0.22 \% + 570 \mu\text{A}$	
	1.00000 μΑ	50 pA	0.035% + 600 pA	10 pA	0.029% + 300 pA	
	10.0000 μA	500 pA	0.033% + 2  nA	100 pA	0.027% + 700 pA	
	100.000 μΑ	5 nA	0.031% + 20 nA	1 nA	0.025% + 6 nA	
2410, 2410-C	1.00000 mA	50 nA	0.034% + 200 nA	10 nA	0.027% + 60 nA	±1.05A @ ±21 V
	20.0000 mA	500 nA	$0.045\% + 4 \mu A$	100 nA	$0.035\% + 1.2 \mu\text{A}$	±21 mA @ ±1100 V
	100.000 mA	5 μΑ	$0.066\% + 20 \mu\text{A}$	$1\mu\mathrm{A}$	$0.055\% + 6 \mu A$	
	$1.00000\mathrm{A}^2$	50 μA	$0.27 \% + 900 \mu A$	$10 \mu A$	$0.22 \% + 570 \mu A$	
	10.0000 μΑ	500 pA	0.033% + 2 nA	100 pA	0.027% + 700 pA	
	100.000 μΑ	5 nA	0.031% + 20 nA	1 nA	0.025% + 6 nA	
	1.00000 mA	50 nA	0.034% + 200 nA	10 nA	0.027% + 60 nA	±3.15A @ ±21 V
2420, 2420-С	10.0000 mA	500 nA	$0.045\% + 2 \mu A$	100 nA	0.035% + 600 nA	
,	100.000 mA	5 μΑ	$0.066\% + 20 \mu\text{A}$	$1 \mu \text{A}$	$0.055\% + 6 \mu A$	±1.05 A @ ±63 V
	$1.00000~\mathrm{A}^2$	50 μA	$0.067\% + 900 \mu\text{A}$	10 μA	$0.066\% + 570 \mu\text{A}$	
	3.00000 A <sup>2</sup>	50 μA	0.059% + 2.7 mA	10 μA	0.052% + 1.71 mA	
	10.0000 μΑ	500 pA	0.033% + 2 nA	100 pA	0.027% + 700 pA	
	$100.000 \mu\text{A}$	5 nA	0.031% + 20 nA	1 nA	0.025% + 6 nA	
	1.00000 mA	50 nA	0.034% + 200 nA	10 nA	0.027% + 60 nA	_
2425, 2425-C	10.0000 mA	500 nA	$0.045\% + 2 \mu A$	100 nA	0.035% + 600 nA	±3.15A @ ±21 V
	100.000 mA	5 μΑ	$0.066\% + 20 \mu\text{A}$	1 μΑ	$0.055\% + 6 \mu A$	±1.05 A @ ±105 V
	$1.00000~\mathrm{A}^2$	50 μA	$0.067\% + 900 \mu\text{A}$	10 μA	$0.060\% + 570 \mu\text{A}$	
	3.00000 A <sup>2</sup>	50 μA	0.059% + 2.8 mA	10 μΑ	0.052% + 1.71 mA	
	10.0000 μΑ	500 pA	0.033% + 2 nA	100 pA	0.027% + 700 pA	
	100.000 μA	5 nA	0.031% + 20 nA	1 nA	0.025% + 6 nA	
	1.00000 mA	50 nA	0.034% + 200 nA	10 nA	0.027% + 60 nA	±1.05A @ ±105 V
2/20 2/20 6	10.0000 mA	500 nA	$0.045\% + 2 \mu A$	100 nA	0.035% + 600 nA	
2430, 2430-С	100.000 mA	5 μΑ	$0.066\% + 20 \mu\text{A}$	1 μΑ	$0.055\% + 6 \mu A$	±10.5 A @ ±105 V
	1.00000 A	50 μA	$0.067\% + 900 \mu\text{A}$	10 μA	$0.060\% + 570 \mu\text{A}$	(pulse mode only)
	$3.00000\mathrm{A}^2$	500 μA	0.059% + 2.8 mA	10 μA	0.052% + 1.71 mA	
	10.00000 A <sup>4</sup>	500 μA	0.089% + 5.9 mA	10 μΑ	0.082% + 1.71 mA	
	$10.0000\mu\mathrm{A}$	500 pA	0.033% + 2 nA	100 pA	0.027% + 700 pA	
	$100.000\mu\mathrm{A}$	5 nA	0.031% + 20 nA	1 nA	0.025% + 6 nA	
	1.00000 mA	50 nA	0.034% + 200 nA	10 nA	0.027% + 60 nA	+5 25A @ +10 5 V
2440, 2440-С	10.0000 mA	500 nA	$0.045\% + 2 \mu A$	100 nA	0.035% + 600 nA	±5.25A @ ±10.5 V ±1.05 A @ ±42 V
	100.000 mA	$5 \mu \mathrm{A}$	$0.066\% + 20 \mu\text{A}$	$1\mu\mathrm{A}$	$0.055\% + 6 \mu A$	±1.0) A @ ±42 V
	1.00000 A	50 μA	$0.067\% + 900 \mu\text{A}$	$10\mu\mathrm{A}$	$0.060\% + 570 \mu\text{A}$	
	5.00000 A	$50 \mu A$	0.10% + 5.4  mA	$10 \mu\text{A}$	0.10 % + 3.42 mA	

TEMPERATURE COEFFICIENT (0°-18°C and 28°-50°C): ±(0.15 × accuracy specification)/°C. CURRENT REGULATION: Line: 0.01% of range. Load: 0.01% of range (except Model 2440 5A range 0.05%) + 100pA.

VOLTAGE LIMIT: Bipolar voltage limit (compliance) set with single value. Min. 0.1% of range. OVERSHOOT: <0.1% typical (1mA step, RL =  $10k\Omega$ , 20V range for Model 2400, 2401, 2410, 2420, 2425, 2430), (10V range for Model 2440).

### **CONTACT CHECK SPECIFICATIONS (requires -C version)**

(Not available for Model 2401)

SPEED:  $350\mu s$  for verification and notification.

CONTACT CHECK:	2 Ω	15 Ω	50 Ω	
No contact check failure	<1.00 Ω	<13.5 Ω	<47.5 Ω	
Always contact check failure	>3.00 Ω	>16.5 Ω	>52.5 Ω	

#### NOTES

- 2400, 2401, 2410 Only: Specifications valid for continuous output currents below 105mA. For operation above 105mA continuous for >1 minute, derate accuracy 10%/35mA above 105mA.
- 2. Full operation (1A) regardless of load to 30°C (50°C for Model 2420 and 2440). Above 30°C (50°C for Model 2420 and 2440) ambient, derate 35mA/°C and prorate 35mA/Ω load. 4-wire mode. For current sink operation on 1A, 3A, or 5A ranges, maximum continuous power is limited to approximately 1/2 rated power or less, depending on current, up to 30°C ambient. See power equations in the User's Manual to calculate allowable duty cycle for specific conditions.
- For sink mode, 1µA to 100mA range, accuracy is: Model 2400, 2401: ±(0.15% + offset\*4). Models 2410, 2420, 2425, 2430, 2440: ±(0.5% + offset\*3). For 1A range, accuracy is:
- Model 2400, 2401: ±(1.5% + offset\*8). Models 2410, 2420, 2425, 2430, 2440: ±(1.5% + offset\*3).
- 10A range only in pulse mode. Limited to 2.5ms pulse width maximum. 10% duty cycle maximum.
   Speed = Normal (1 PLC). For 0.1 PLC, add 0.005% of range to offset specifications, except 200mV, 1A, 10A ranges, add 0.05%. For 0.01 PLC, add 0.05% of range to offset specifications, except 200mV, 1A, 10A ranges, add 0.5%.
- $6. \ \ Accuracies apply to 2- or 4-wire mode when properly zeroed.$
- 7. In pulse mode, limited to 0.1 PLC measurement.
- 8. Model 2400 and 2400-C only.



# SourceMeter® SMU Instruments

### Resistance Measurement Accuracy (Local or Remote Sense)1, 2, 5

	Default	Default Test Current	Default Test Current 2420, 2425,	N	Normal Accuracy (23°C 1 Year, ±(% rdg. + oh		Enhanced Accuracy (23°C ±5°C) <sup>4</sup> 1 Year, ±(% rdg. + ohms)
Range	Resolution	2400, 2401, 2410	2430, 2440	2400, 2401	2410	2420, 2425, 2430, 2440	2400, 2401
$< 0.20000 \Omega^{3}$	-	-	-	Source I <sub>ACC</sub> + Meas. V <sub>ACC</sub>			
$2.00000 \Omega^{3}$	$10 \mu\Omega$	-	1 A	Source I <sub>ACC</sub> + Meas V <sub>ACC</sub>	Source I <sub>ACC</sub> + Meas. V <sub>ACC</sub>	$0.17\% + 0.0003\Omega$	Source I <sub>ACC</sub> + Meas. V <sub>ACC</sub>
$20.0000$ $\Omega$	$100 \mu\Omega$	100 mA	100 mA	$0.10\% +  0.003 \; \Omega$	$0.11\% + 0.006 \Omega$	$0.10\% + 0.003 \Omega$	$0.07\% + 0.001 \Omega$
$200.000$ $\Omega$	$1~\text{m}\Omega$	10 mA	10 mA	$0.08\% + 0.03 \Omega$	$0.09\% + 0.1 \Omega$	$0.08\% + 0.03 \Omega$	$0.05\% + 0.01$ $\Omega$
$2.00000\ k\Omega$	$10 \text{ m}\Omega$	1 mA	1 mA	$0.07\% + 0.3 \Omega$	$0.08\% + 0.6 \Omega$	$0.07\% + 0.3 \Omega$	$0.05\% + 0.1$ $\Omega$
$20.0000~k\Omega$	$100 \text{ m}\Omega$	$100~\mu A$	$100~\mu A$	$0.06\% + 3 \Omega$	$0.07\% + 6 \Omega$	$0.06\% + 3 \Omega$	$0.04\% + 1$ $\Omega$
$200.000~k\Omega$	1 $\Omega$	$10~\mu A$	$10 \mu A$	$0.07\% + 30 \Omega$	$0.07\% + 60 \Omega$	$0.07\% + 30$ $\Omega$	$0.05\% + 10$ $\Omega$
$2.00000~\text{M}\Omega^6$	10 Ω	$1~\mu A$	1 μΑ	$0.11\% + 300$ $\Omega$	$0.12\% + 600$ $\Omega$	$0.11\% + 300$ $\Omega$	$0.05\% + 100$ $\Omega$
$20.0000~\text{M}\Omega^7$	$100$ $\Omega$	$1~\mu\mathrm{A}$	$1 \mu A$	$0.11\% + 1 k\Omega$	$0.12\%$ + $2.4$ k $\Omega$	$0.11\% + 1 k\Omega$	$0.05\% + 500$ $\Omega$
$200.000~\text{M}\Omega^3$	1 k $\Omega$	100 nA	-	$0.66\% + 10 \text{ k}\Omega$	$0.66\% + 24 k\Omega$	Source I <sub>ACC</sub> + Meas. V <sub>ACC</sub>	$0.35\% + 5$ k $\Omega$
$>$ 200.000 M $\Omega$ <sup>3</sup>	-	-	-	Source $I_{ACC}$ + Meas. $V_{ACC}$			

TEMPERATURE COEFFICIENT (0°-18°C and 28°-50°C): ±(0.15 × accuracy specification)/°C.

SOURCE I MODE, MANUAL OHMS: Total uncertainty = I source accuracy + V measure accuracy (4-wire remote sense).

**SOURCE V MODE, MANUAL OHMS:** Total uncertainty = V source accuracy + I measure accuracy (4-wire remote sense).

**6-WIRE OHMS MODE:** Available using active ohms guard and guard sense. Max. Guard Output Current: 50mA (except 1A range). Accuracy is load dependent. Refer to White Paper no. 2033 for calculation formula.

GUARD OUTPUT IMPEDANCE:  $< 0.1\Omega$  in ohms mode.

#### NOTES

- Speed = Normal (1 PLC). For 0.1 PLC, add 0.005% of range to offset specifications, except 200mV, 1A, 10A ranges, add 0.05%. For 0.01 PLC, add 0.05% of range to offset specifications, except 200mV, 1A, 10A ranges, add 0.5%.
   Accuracies apply to 2- or 4-wire mode when properly zeroed.
- 3. Manual ohms only except 2420, 2425, 2430, 2440 for  $2\Omega$  range and 2400, 2401, or 2410 for  $200M\Omega$  range. Source readback enabled, offset compensation ON. Also available on 2410, 2420, 2425, 2430, and 2440 with similar accuracy
- enhancement.
- 5. In pulse mode, limited to 0.1 PLC measurement.
- 6. Except 2440; default test current is  $5\mu A$ . Except 2440; default test current is 0.5μA.

#### **SERVICES AVAILABLE**

2400-3Y-EW	1-year factory warranty extended to 3 years from date of shipment
2400-C-3Y-EW	1-year factory warranty extended to 3 years from date of shipment
2401-3Y-EW	1-year factory warranty extended to 3 years from date of shipment
2410-3Y-EW	1-year factory warranty extended to 3 years from date of shipment
2410-C-3Y-EW	1-year factory warranty extended to 3 years from date of shipment
2420-3Y-EW	1-year factory warranty extended to 3 years from date of shipment
2420-C-3Y-EW	1-year factory warranty extended to 3 years from date of shipment
2425-3Y-EW	1-year factory warranty extended to 3 years from date of shipment
2425-C-3Y-EW	1-year factory warranty extended to 3 years from date of shipment
2430-3Y-EW	1-year factory warranty extended to 3 years from date of shipment
2430-C-3Y-EW	1-year factory warranty extended to 3 years from date of shipment
2440-3Y-EW	1-year factory warranty extended to 3 years from date of shipment
2440-C-3Y-EW	1-year factory warranty extended to 3 years from date of shipment
C/2400-3Y-ISO	3 (ISO-17025 accredited) calibrations within 3 years of purchase for Models 2400, 2400-C, 2400-LV*
C/2401-3Y-ISO	3 (ISO-17025 accredited) calibrations within 3 years of purchase for Model 2401*
C/2410-3Y-ISO	3 (ISO-17025 accredited) calibrations within 3 years of purchase for Models 2410, 2410-C*
C/2420-3Y-ISO	3 (ISO-17025 accredited) calibrations within 3 years of purchase for Models 2420, 2420-C*
C/2425-3Y-ISO	3 (ISO-17025 accredited) calibrations within 3 years of purchase for Models 2425, 2425-C*
C/2430-3Y-ISO	3 (ISO-17025 accredited) calibrations within 3 years of purchase for Models 2430, 2430-C*
C/2440-3Y-ISO	3 (ISO-17025 accredited) calibrations within 3 years of purchase for Models 2440, 2440-C*
TRN-2400-1-C	Course: Unleashing the Power of Your SourceMeter SMU Instrument
*Not available in	all countries

\*Not available in all countries





# SourceMeter® SMU Instruments

### **System Speeds**

#### MEASUREMENT<sup>1</sup>

MAXIMUM RANGE CHANGE RATE: 75/second.

MAXIMUM MEASURE AUTORANGE TIME: 40ms (fixed source).2

### Sweep Operation<sup>3</sup> Reading Rates (rdg./second) for 60Hz (50Hz):

						Source-N			
		Mea	sure	Source-l	Measure	Pass/Fai	il Test <sup>4, 5</sup>	Source-N	/lemory⁴
Speed	NPLC/Trigger Origin	To Mem.	To GPIB	To Mem.	To GPIB	To Mem.	To GPIB	To Mem.	To GPIB
Fast	0.01 / internal	2081 (2030)	1754	1551 (1515)	1369	902 (900)	981	165 (162)	165
IEEE-488.1 Mode	0.01 / external	1239 (1200)	1254	1018 (990)	1035	830 (830)	886	163 (160)	163
Fast	0.01 / internal	2081 (2030)	1198 (1210)	1551 (1515)	1000 (900)	902 (900)	809 (840)	165 (162)	164 (162)
IEEE-488.2 Mode	0.01 / external	1239 (1200)	1079 (1050)	1018 (990)	916 (835)	830 (830)	756 (780)	163 (160)	162 (160)
Medium	0.10 / internal	510 (433)	509 (433)	470 (405)	470 (410)	389 (343)	388 (343)	133 (126)	132 (126)
IEEE-488.2 Mode	0.10 / external	438 (380)	438 (380)	409 (360)	409 (365)	374 (333)	374 (333)	131 (125)	131 (125)
Normal	1.00 / internal	59 (49)	59 (49)	58 (48)	58 (48)	56 (47)	56 (47)	44 (38)	44 (38)
IEEE-488.2 Mode	1.00 / external	57 (48)	57 (48)	57 (48)	57 (47)	56 (47)	56 (47)	44 (38)	44 (38)

#### Single Reading Operation Reading Rates (rdg./second) for 60Hz (50Hz):

		Measure	Source-Measure⁵	Source-Measure Pass/Fail Test <sup>4,5</sup>
Speed	NPLC/Trigger Origin	To GPIB	To GPIB	To GPIB
Fast (488.1)	0.01 / internal	537	140	135
Fast (488.2)	0.01 / internal	256 (256)	79 (83)	79 (83)
Medium (488.2)	0.10 / internal	167 (166)	72 (70)	69 (70)
Normal (488.2)	1.00 / internal	49 (42)	34 (31)	35 (30)

### Component for 60Hz (50Hz):4,6

Speed	NPLC/Trigger Origin	Measure To GPIB	Source Pass/Fail Test	Source-Measure Pass/Fail Test <sup>5, 7</sup> To GPIB
Fast	0.01 / external	1.04 ms (1.08 ms)	0.5 ms (0.5 ms)	4.82 ms (5.3 ms)
Medium	0.10 / external	2.55 ms (2.9 ms)	0.5 ms (0.5 ms)	6.27 ms (7.1 ms)
Normal	1.00 / external	17.53 ms (20.9 ms)	0.5 ms (0.5 ms)	21.31 ms (25.0 ms)

#### NOTES

- <sup>1</sup> Reading rates applicable for voltage or current measurements. Auto zero off, autorange off, filter off, display off, trigger delay = 0, and binary reading format.
- $^2~$  Purely resistive lead.  $1\mu \text{A}$  and  $10\mu \text{A}$  ranges <65ms.
- 3 1000 point sweep was characterized with the source on a fixed range.

- <sup>4</sup> Pass/Fail test performed using one high limit and one low math limit.
- $^{\rm 5}\,$  Includes time to re-program source to a new level before making measurement.
- <sup>6</sup> Time from falling edge of START OF TEST signal to falling edge of END OF TEST signal.
- Ommand processing time of :SOURce:VOLTage | CURRent:TRIGgered <nrf> command not included.

### **GENERAL**

### Noise Rejection:

	NPLC	NMRR	CMRR
Fast	0.01	_	80 dB
Medium	0.1	_	80 dB
Slow	1	60 dB	100 dB1

<sup>&</sup>lt;sup>1</sup>Except lowest 2 current ranges = 90dB.

LOAD IMPEDANCE: Stable into 20,000pF typical.

COMMON MODE VOLTAGE: 250V DC (40V DC for Model 2440).

COMMON MODE ISOLATION:  $>10^{9}\Omega$ , <1000pF. OVERRANGE: 105% of range, source and measure.

MAX. VOLTAGE DROP BETWEEN INPUT/OUTPUT AND SENSE TERMINALS: 5V.

MAX. SENSE LEAD RESISTANCE:  $1M\Omega$  for rated accuracy.

SENSE INPUT IMPEDANCE:  $>10^{10}\Omega$ .

GUARD OFFSET VOLTAGE: <150 $\mu$ V, typical (300 $\mu$ V for Models 2430, 2440).

SOURCE OUTPUT MODES:

Pulse (Model 2430 only)

Fixed DC level

Memory List (mixed function)

Stair (linear and log)

MEMORY BUFFER: 5,000 readings @ 5 digits (two 2,500 point buffers). Includes selected measured value(s) and time stamp. Lithium battery backup (3 yr+ battery life).

SOURCE MEMORY LIST: 100 points max.

 $\label{eq:programmability: IEEE-488 (SCPI-1995.0), RS-232, 5 user-definable power-up states plus factory default and *RST.$ 

DIGITAL INTERFACE:

Interlock: Active low input.

Handler Interface: Start of test, end of test, 3 category bits. +5V@ 300mA supply. Not available on Model 2401.

Digital I/O: 1 trigger input, 4 TTL/Relay Drive outputs (33V @ 500mA, diode clamped). Not available on Model 2401.

POWER SUPPLY: 100V to 240V rms, 50–60Hz (automatically detected at power up). Model 2400, 2401: 190VA. Model 2410: 210VA. Model 2420: 220VA. Model 2425, 2430: 250VA. Model 2440: 240VA.

COOLING: Model 2401: Convection. Model 2410, 2420, 2425, 2430, 2440: Forced air, variable speed.

**EMC:** Conforms to European Union Directive 89/336/EEC, EN 61326-1.

SAFETY: UL listed to UL 61010B-1:2003: Conforms to European Union Low Voltage Directive. VIBRATION: MIL-PRF-28800F Class 3 Random.

WARM-UP: 1 hour to rated accuracies.

DIMENSIONS: 89mm high  $\times$  213mm wide  $\times$  370mm deep ( $3\frac{1}{2}$  in  $\times$  8% in  $\times$  14% in). Bench Configuration (with handle and feet):104mm high  $\times$  238mm wide  $\times$  370mm deep ( $4\frac{1}{2}$  in  $\times$  9% in  $\times$  14% in).

WEIGHT: 3.21kg (7.08 lbs) (Model 2425, 2430, 2440: 4.1kg, 9.0 lbs).

ENVIRONMENT: Operating: 0°–50°C, 70% R.H. up to 35°C. Derate 3% R.H./°C, 35°–50°C. Storage: -25°C to 65°C.



## **Mouser Electronics**

**Authorized Distributor** 

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Keithley Instruments, Inc.:

<u>2410-C</u> <u>2430-C</u> <u>2400</u> <u>2420-C</u> <u>2401</u> <u>2440-C</u> <u>2440</u> <u>2430</u> <u>2425-C</u> <u>2400-C</u> <u>2425</u> <u>2410</u> <u>2420</u>